Canadian \$ Secondary Ion Mass Spectrometry (SIMS) \$140.00/hour Cameca IMS-3f with oxygen or caesium source and Cameca IMS-6f with oxygen or caesium source ION-TOF TOF-SIMS IV with Ga+, Cs+, SF5+, Ar+, O+, and C6O+ beams, 8" sample stage \$140.00/hour X-ray Photoelectron Spectroscopy (XPS) Kratos AXIS Supra \$140.00/hour Kratos AXIS Nova \$140.00/hour **Auger Electron Spectroscopy (AES)** PHI 710 Field Emission Scanning Auger Nanoprobe \$140.00/hour Scanning Electron Microscopy (SEM) with Energy Dispersive X-ray (EDX) Spectroscopy Hitachi SU8230 Regulus Ultra High-Resolution Field Emission SEM \$120.00/hour Bruker X-Flash FQ5060 Annular Quad X-ray Analyzer Bruker X-Flash 6160 X-ray Analyzer Hitachi SU3900 Variable Pressure Large Chamber SEM with an Oxford ULTIMAX 65 SDD X-ray Analyzer \$120.00/hour Hitachi SU3500 Variable Pressure SEM with an Oxford Aztec X-Max50 SDD X-ray Analyzer \$120.00/hour **Atomic Force Microscopy (AFM)** Park Systems XE-100 \$120.00/hour **Surface Profilometry** KI A-Tencor-17 \$120.00/hour Ziess LSM800 Confocal Laser Scanning Microscope \$120.00/hour **Laser Raman Spectroscopy** Renishaw 2000 \$140.00/hour Fourier Transform Infrared (FTIR) Spectroscopy Bruker Tensor II System with Hyperion 2000 Microscope \$140.00/hour **Optical Microscopy** Zeiss Axioplan, Zeiss SteREO Discovery. V8, and Wild M3Z \$60.00/hour Keyence VHX-6000 \$60.00/hour **Contact Angle Goniometry** KRÜSS Drop Shape Analyzer DSA30E \$110.00/hour **Microindentation Hardness Testing** Leco LM100 \$60.00/sample **Metallographic Preparation** Per sample \$70.00/sample **Etching** Standard \$70.00/sample **Differential Scanning Calorimetry (DSC)** Mettler Toledo DSC 3 \$70.00/sample Thermogravimetric Analysis (TGA) Mettler Toledo TGA 2 \$70.00/sample X-ray Diffraction (XRD) Rigaku SmartLab with a 2D Hypix-3000 detector \$120.00/hour **Micro Computed Tomography (Micro-CT)** Zeiss Xradia 410 Versa Micro-CT \$400/per overnight run Zeiss Xradia 410 Versa Micro-CT \$70/per daytime hour **Weathering Chambers** Q-FOG CRH Cyclic Corrosion Tester Please call for a quote Q-SUN Xe-3 Xenon Arc Test Chamber Please call for a quote QUV/Spray Accelerated Weathering Chamber Please call for a quote Priority Service (based on Monday - Friday business hours, excluding weekends and holidays) Five business days 25% surcharge Three business days 50% surcharge 100% surcharge One business day Advanced Reporting, Consulting, Data Interpretation, Post-analytical Data Processing, Sample Preparation Hourly basis \$140.00/hour **Project Administration Fee** One-time flat fee, per job \$21.50